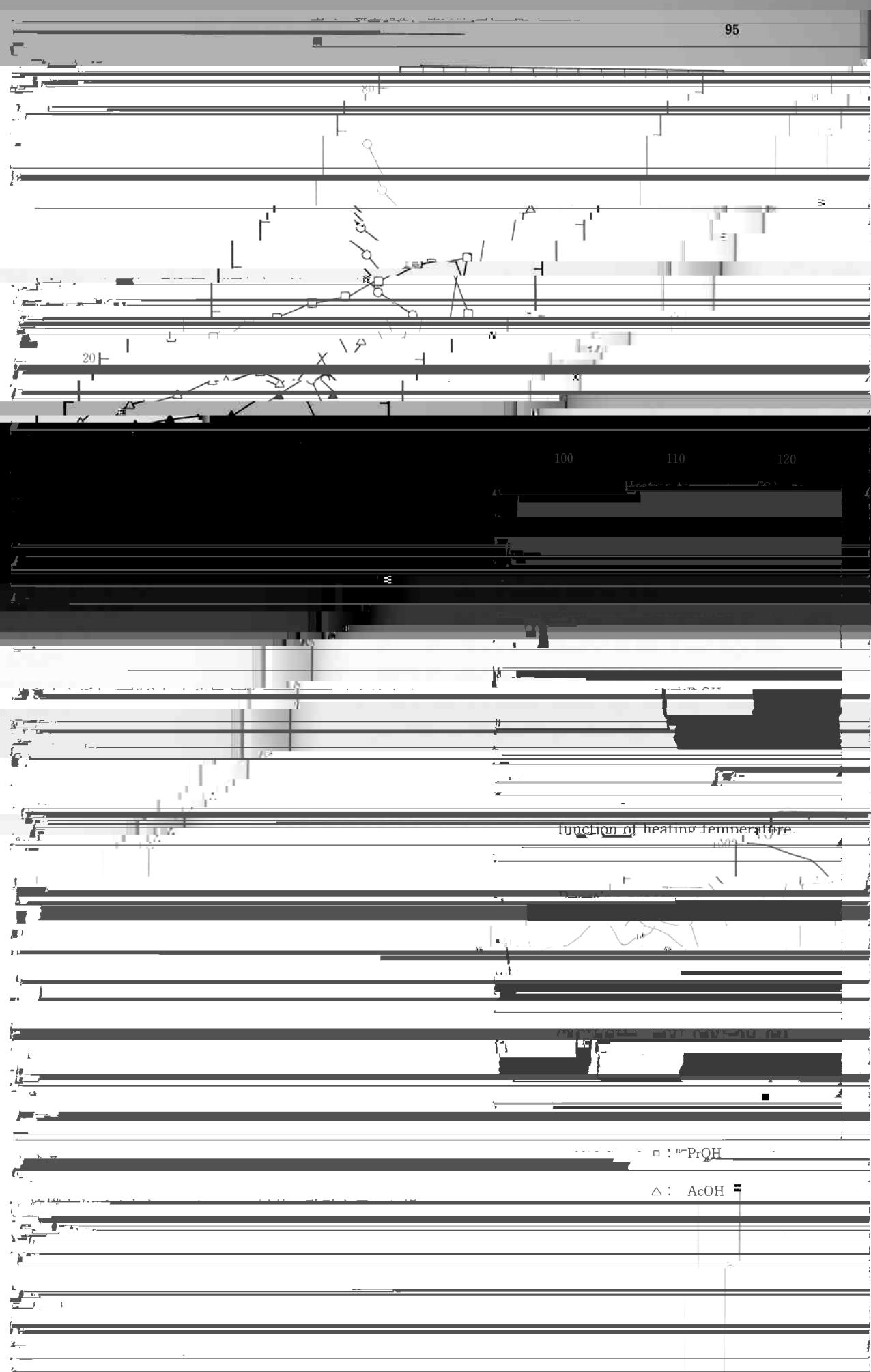


Fig. 1. Schematic processes for preparation of thin films.





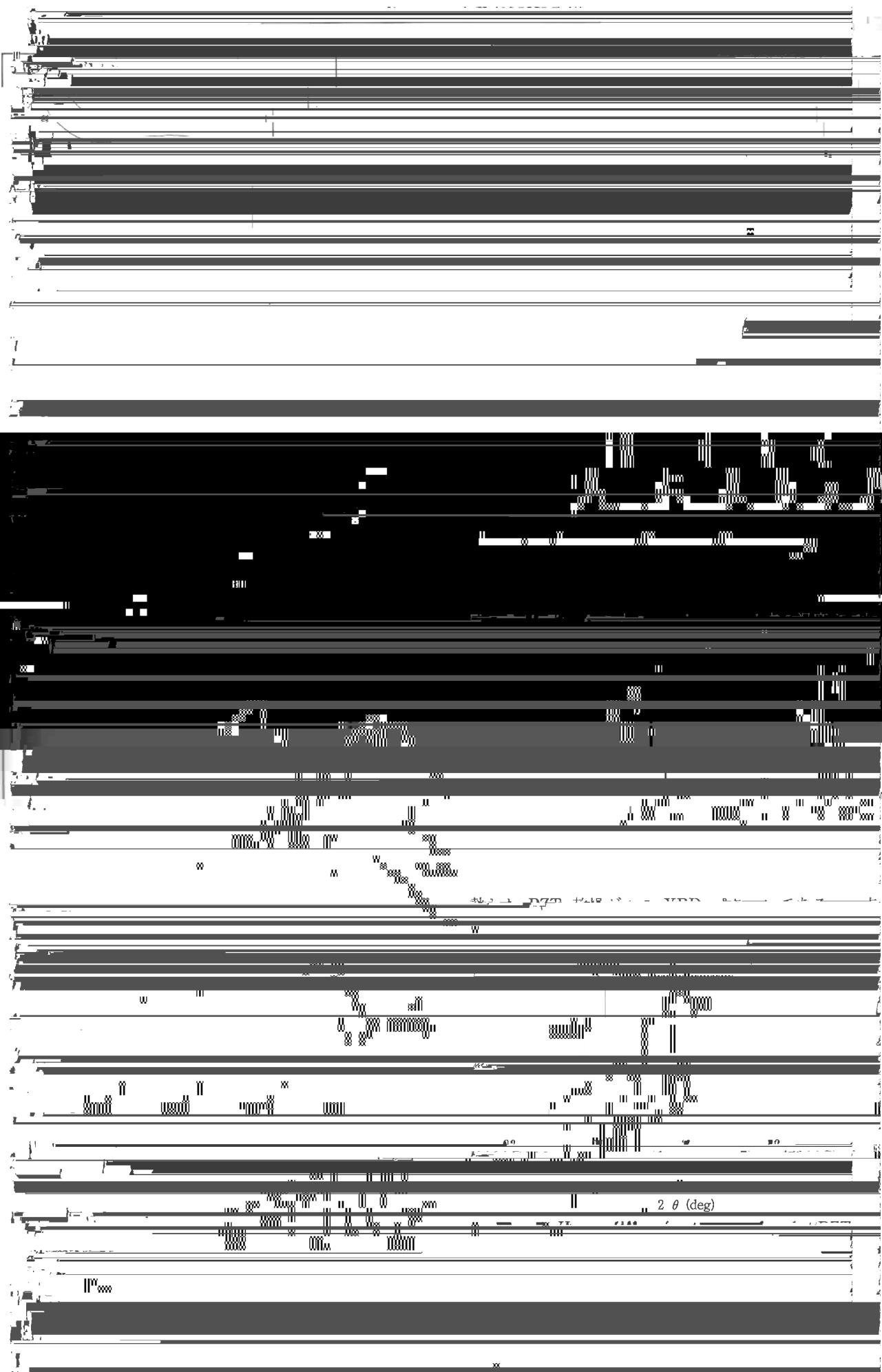


Table 1 Electric properties of the PZT thin film and bulk ceramics

Figure 1 displays the dielectric properties of P(VDF-TrFE) films with different thicknesses (d) as a function of frequency (f). The subplots show the dielectric constant (ϵ), loss tangent ($\tan \delta$), polarization (P_r), and polarization reversal field (E_r) versus frequency (f).

d (μm)	$\epsilon(1\text{ kHz})$	$\tan \delta(1\text{ kHz})$	$P_r(\text{nC/cm}^2)$	$E_r(\text{kV/cm})$
1.0	~100	~0.02	~1.5	~100
1.5	~100	~0.02	~1.5	~100
2.0	~100	~0.02	~1.5	~100
3.0	~100	~0.02	~1.5	~100
4.0	~100	~0.02	~1.5	~100
5.0	~100	~0.02	~1.5	~100
6.0	~100	~0.02	~1.5	~100
7.0	~100	~0.02	~1.5	~100
8.0	~100	~0.02	~1.5	~100
9.0	~100	~0.02	~1.5	~100
10.0	~100	~0.02	~1.5	~100





4) A. Okada; *J. Appl. Phys.*, **48**, 2905, (1977)

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